



EUROFINS PRODUCT TESTING SERVICE (SHANGHAI) CO., LTD.

EMC TEST- REPORT

TEST REPORT NUMBER: EFSH15091512-IE-01-E01



Eurofins Product Testing Service (Shanghai) Co., Ltd.
No.395 West Jiangchang Road, Zhabei District, Shanghai,
200436, P.R. China

Phone: +86-21-61819181
Fax: +86-21-61819180
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2 General Information

2.1 Notes

The results of this test report relate exclusively to the item tested as specified in chapter "Description of test item" and are not transferable to any other test items.

Eurofins Product Testing Service (Shanghai) is not responsible for any generalisations and conclusions drawn from this report. Any modification of the test item can lead to invalidity of test results and this test report may therefore be not applicable to the modified test item.

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Operator:

2015-10-27

Stefan Zhao / Project Engineer



Date

Eurofins-Lab.

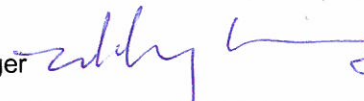
Name/ Title

Signature

Technical responsibility for area of testing:

2015-10-27

Teddy Wang / Technical Manager



Date

Eurofins

Name/ Title

Signature

Test Report No.: EFSH15091512-IE-01-E01

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2.2 Testing laboratory

Eurofins Product Testing Service (Shanghai) Co., Ltd.

No.395 West Jiangchang Road, Zhabei District, Shanghai, 200436, P.R. China

Telephone : +86-21-61819181

Telefax : +86-21-61819180

Test location, where different:

Subcontractor

Name : BUREAU VERITAS ADT (SHANGHAI) CORPORATION.

Address : 2F, Building C, No. 1618 Yishan Road SHANGHAI

Telephone : + 86-21-6465 9091

Fax : + 86-21-6465 9092

Radiated emission and Radiated immunity tests were performed by Stefan Zhao at BUREAU VERITAS ADT (SHANGHAI) CORPORATION.

2.3 Details of approval holder

Name : Xindao B.V.
Address : P.O. Box 3082, 2280 GB, Rijswijk, The Netherlands
Telephone : ./.
Fax : ./.

2.4 Application details

Date of receipt of application : 2015-10-14
Date of receipt of test item : 2015-10-14
Date of test : 2015-10-14 to 2015-10-27

2.5 EUT information

Product type : 2500mAh ultra slim powerbank
Model name : P324.85
Brand Name : ./.
Serial number : ./.
Power supply : Input: DC5V/1A, 2500mAh
Output (Micro USB): DC5V/1A
Output (USB port) : DC5V/1A
Additional information : The appliance is powerbank.
Adapter was used as test accessory.
Adapter model: AKN2G-0500210VU
Input:100-240V~ 50/60Hz 0.35A,
Output: DC 5V 2.1A

2.6 Test standards

Technical standard :

EN 55022:2010/AC:2011

EN 55024:2010

EN 61000-3-2:2014

EN 61000-3-3:2013

3 Technical test

3.1 Summary of test results

No deviations from the technical specification(s) were ascertained in the course of the tests performed.



or

The deviations as specified were ascertained in the course of the tests performed.



3.2 Test environment

Eurofins Product Testing Service (Shanghai) Co., Ltd.

Temperature : 20 ... 25°C
Relative humidity content : 30 ... 60%
Air pressure : 100 ... 103kPa

BUREAU VERITAS ADT (SHANGHAI) CORPORATION.

Temperature : 24°C
Relative humidity content : 41%
Air pressure : 101kPa

3.3 Test equipment utilized

Measurement Equipment List				
No.	Name	Model	Manufacturer	Cal. due date
1	EMI test receiver	ESCI	R&S	2015-11-27
2	Triple Loop Antenna	HXYZ 9170	Schwarzbeck	2015-11-27
3	Single phase Harmonics & Flicker analyser	PACS-1	California Instruments	2015-11-27
4	AC Power Source	5001ix	California Instruments	2015-11-27
5	Coupling/Decoupling Network	L 801 M2/M3	Luethi	2015-11-27
6	Ultra Compact Simulator	UCS 500N7	EMTEST	2015-11-27
7	ESD Gun	NSG 437	TESEQ	2015-11-27
8	Current transformer	MC2630	EMTEST	2015-11-27
9	Motorized variac	MV2616	EMTEST	2015-11-27
10	Continuous wave simulator	CWS500N1	EMTEST	2015-11-27
11	Magnetic field coil	MS100	EMTEST	2015-11-27
12	Current transformer	MC26100	EMTEST	2015-11-27
13	Artificial mains	ENV216-DCV	R&S	2015-11-27
14	Shielded Room	4*3*3	Zhong-shuo	2015-11-27
15	Shielded Room	7*4*3	Zhong-shuo	2015-11-27
16	EMI Test Spectrum	E4403B	Agilent	2016-08-24
17	EMI test receiver	ESCS30	R&S	2016-04-13
18	Broadband Antenna	VULB9168	Schwarzbeck	2016-03-26
19	Amplifier	8447D	Agilent	2015-11-06
20	Signal Generator	MG3692B	Anritsu	2016-04-13
21	Logarithmic Periodic Antenna	STCP9128D	Schwarzbeck	2015-11-22
22	Power Amplifier	MT225	AP32	2015-12-04
23	Power meter	4232A/01/02	Boonton	2016-04-13

3.4 Test results

☒ 1st test

☐ test after modification

☐ production test

Test case	Sub clause	Required	Test passed	Test failed
Conducted disturbance at the mains ports	Clause 5.1 of EN 55022	☒	☒	☐
Conducted disturbance at telecommunication ports	Clause 5.2 of EN 55022	☐	☐	☐
Radiated disturbance below 1GHz	Clause 6.1 of EN 55022	☒	☒	☐
Harmonic Current Emissions	EN 61000-3-2	☐	☐	☐
Voltage Changes, Voltage Fluctuations and Flicker	EN 61000-3-3	☒	☒	☐
Electrostatic Discharge	Clause 4.2.1 of EN 55024 & IEC 61000-4-2	☒	☒	☐
Electrical Fast Transients	Clause 4.2.2 of EN 55024 & IEC 61000-4-4	☒	☒	☐
Radio frequency electromagnetic fields	Clause 4.2.3.2 of EN 55024 & IEC 61000-4-3	☒	☒	☐
Injected currents (RF continues conducted)	Clause 4.2.3.3 of EN 55024 & IEC 61000-4-6	☒	☒	☐
Power-frequency magnetic fields	Clause 4.2.4 of EN 55024 & IEC 61000-4-8	☒	☒	☐
Surge immunity	Clause 4.2.5 of EN 55024 & IEC 61000-4-5	☒	☒	☐
Voltage dips and Interruption	Clause 4.2.6 of EN 55024 & IEC 61000-4-11	☒	☒	☐

Note 1: The Harmonic Current Emissions was not required as the rated power of EUT was less than 75W.

Note 2: All the test items which related to AC mains were performed to adapter, and the EUT was connected to adapter during the test.

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4 Emission Test

4.1 Conducted Emission

This clause lays down the general requirements for the measurement of disturbance voltage produced at the terminals of apparatus.

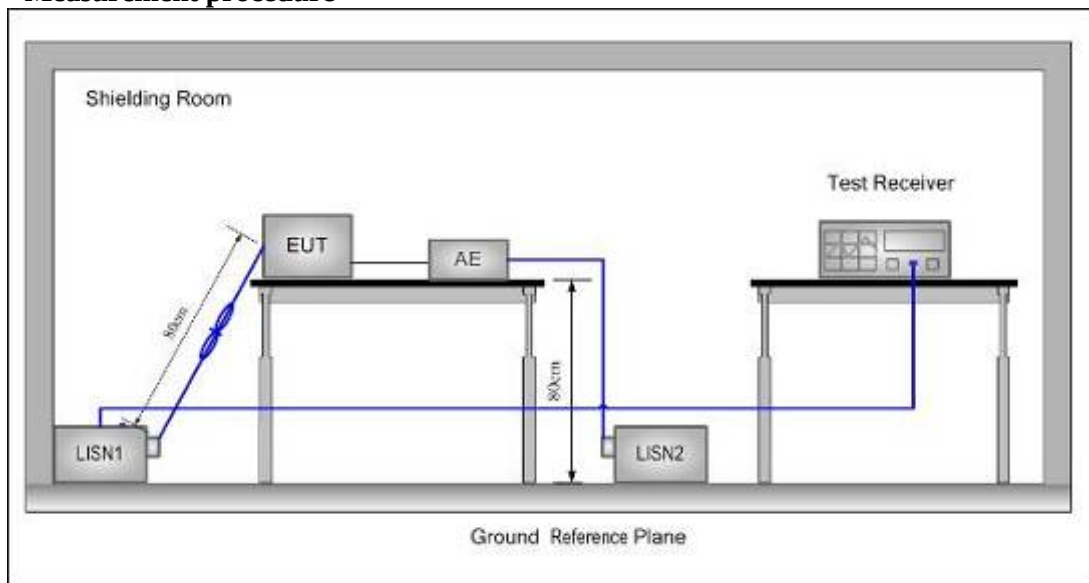
4.1.1 Limits

Class B ITE

Frequency range MHz	At mains terminals dB (μV)	
	Quasi-peak Limit	Average Limit
0.15 to 0.50	66 to 56	56 to 46
0.50 to 5	56	46
5 to 30	60	50

NOTE 1 The lower limit shall apply at the transition frequencies.
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0,15 MHz to 0,50 MHz.

4.1.2 Measurement procedure



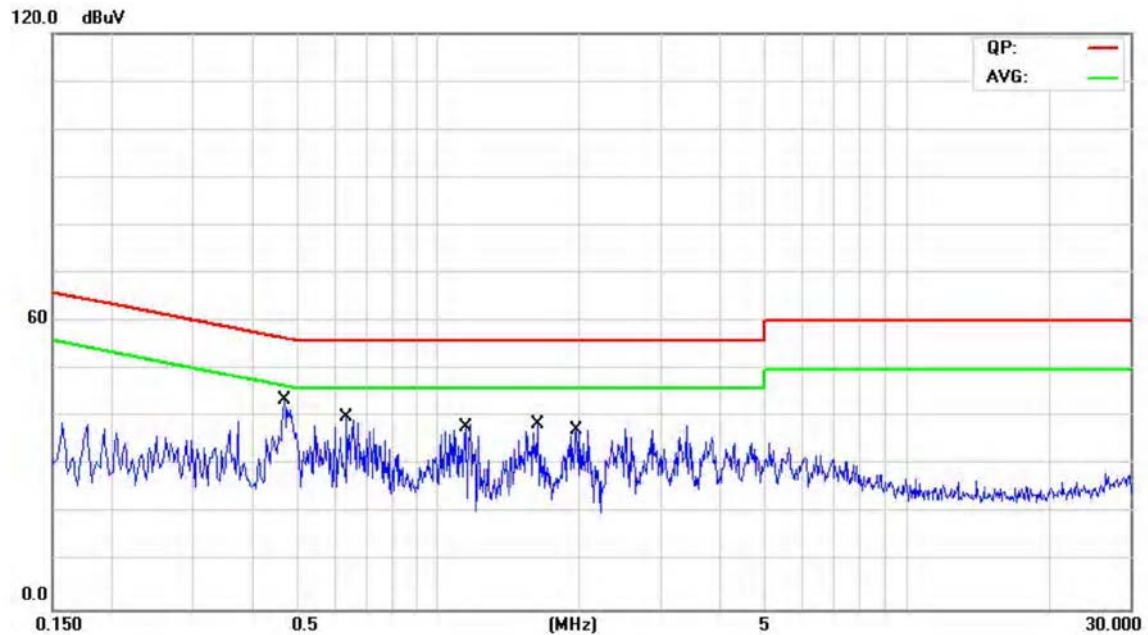
1. The mains terminal disturbance voltage was measured with the EUT in a shielded room.
2. The EUT was connected to AC power source through a LISN (Line Impedance Stabilization Network) which provides a $(50 \mu H + 5 \Omega) \parallel 50 \Omega$ linear impedance. The power cables of all other units of the EUT were connected to a second LISN, which was bonded to the ground reference plane in the same way as the LISN for the unit being measured.
3. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
4. A pre-scan was performed with the peak(PK) and average(AV) detector to find out the maximum emission data plots of the EUT.

4.1.3 Measurement uncertainty

$U_{lab}(cond) = 1.8dB$ at 95% level of confidence, $k=2$

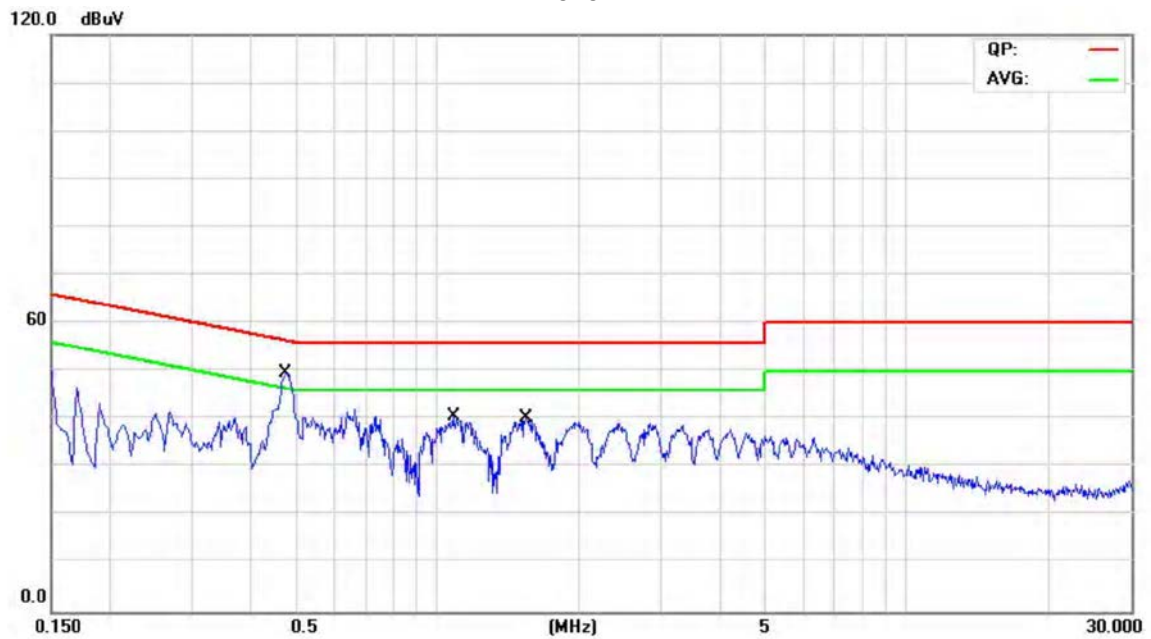
4.1.4 Results -Measurement Data

Live Line:
Level



No.	Mk.	Freq.	Reading	Correct	Measure-	Limit	Over	
		MHz	dBuV	Factor	ment	dBuV	dB	Detector
1		0.4700	28.06	9.73	37.79	56.51	-18.72	QP
2	*	0.4700	18.42	9.73	28.15	46.51	-18.36	AVG
3		0.6380	22.09	9.74	31.83	56.00	-24.17	QP
4		0.6380	12.45	9.74	22.19	46.00	-23.81	AVG
5		1.1460	20.55	9.68	30.23	56.00	-25.77	QP
6		1.1460	11.03	9.68	20.71	46.00	-25.29	AVG
7		1.6300	19.99	9.79	29.78	56.00	-26.22	QP
8		1.6300	10.38	9.79	20.17	46.00	-25.83	AVG
9		1.9780	20.87	9.87	30.74	56.00	-25.26	QP
10		1.9780	11.05	9.87	20.92	46.00	-25.08	AVG

Neutral Line:
Level



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector
1	*	0.4740	37.24	9.72	46.96	56.44	-9.48	QP
2		0.4740	26.64	9.72	36.36	46.44	-10.08	AVG
3		1.0780	27.33	9.67	37.00	56.00	-19.00	QP
4		1.0780	18.51	9.67	28.18	46.00	-17.82	AVG
5		1.5420	27.18	9.77	36.95	56.00	-19.05	QP
6		1.5420	18.39	9.77	28.16	46.00	-17.84	AVG

4.2 Radiated disturbance

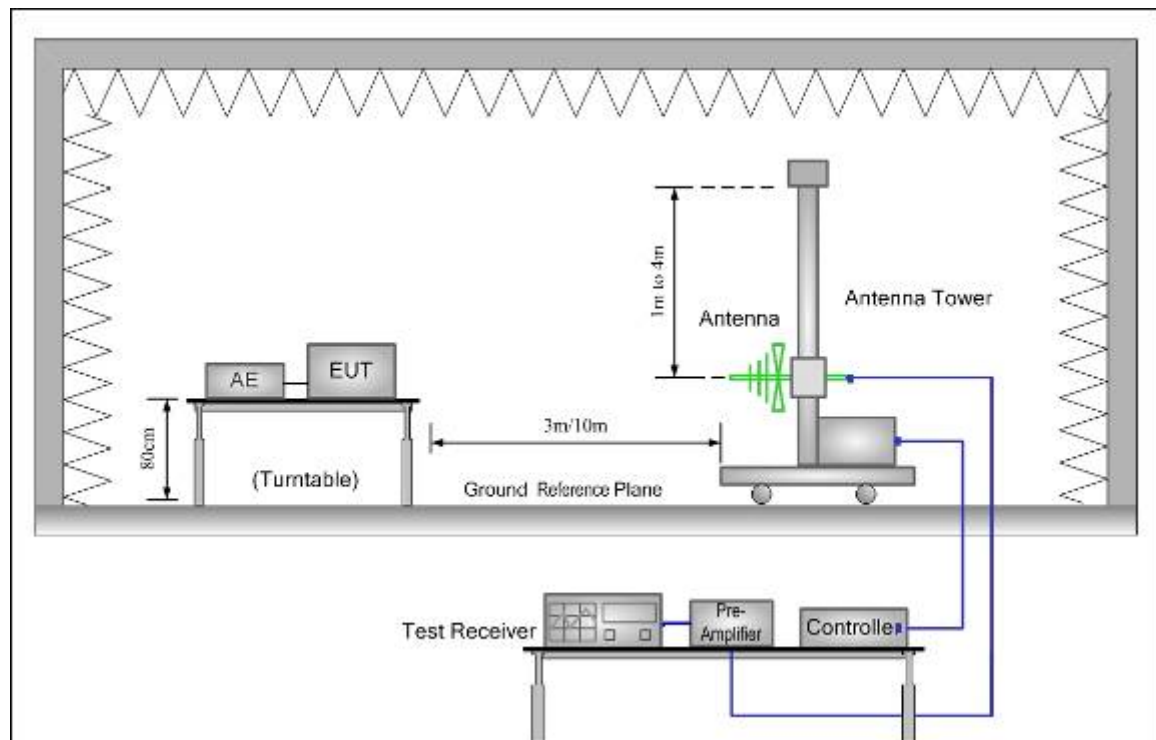
This clause lays down the general requirements for the measurement of Radiated disturbance produced at the space of apparatus.

4.2.1 Limits

Below 1GHz

Frequency range	Quasi-peak limits at 3m
MHz	dB (μ V/m)
30 to 230	40
230 to 1000	47
At transitional frequencies the lower limit applies.	

4.2.2 Measurement procedure



1. The radiated emissions test was conducted in a semi-anechoic chamber. The EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.
2. Before get the final emission results with quasi-peak(QP) detector, a pre-scan was performed with the peak(PK) detector to find out the maximum emission data plots of the EUT.
3. The frequencies of maximum emission were determined in the final radiated emissions measurement, the physical arrangement of the test system and associated cabling was varied in order to determine the effect on the EUT's emissions in amplitude, direction and frequency. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance.

Measurements were performed for both horizontal and vertical antenna polarization. Test was performed on subcontractor.

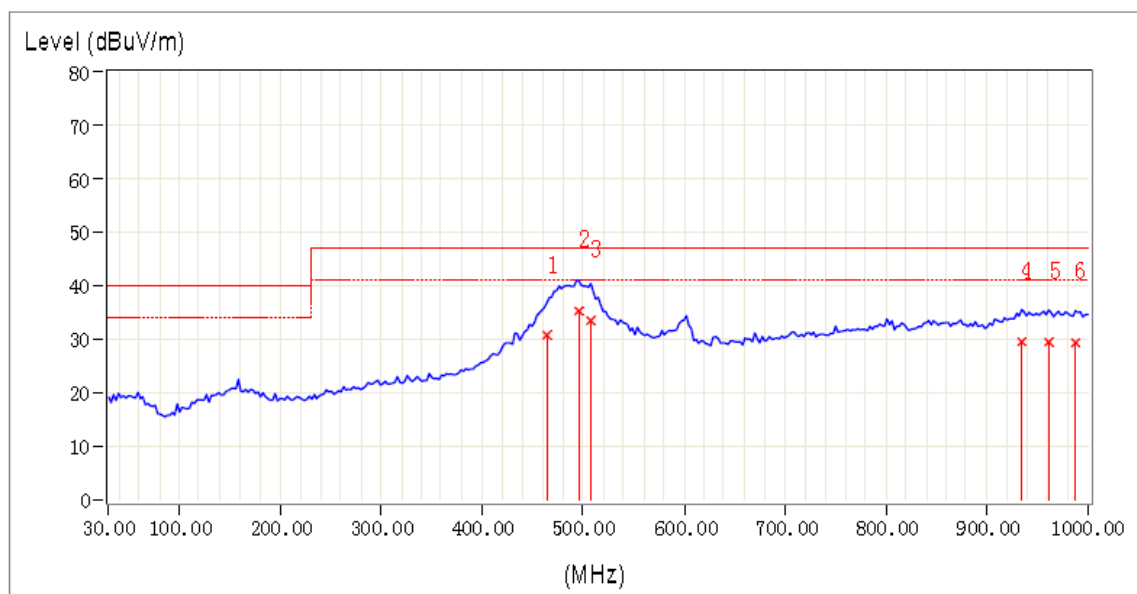
4.2.3 Measurement uncertainty

$U_{lab}(cond) = 3.22\text{dB}$ at 95% level of confidence , $k=2$

4.2.4 Results

Note: Both operating mode and charging mode were tested and the worst mode(operating mode) was recorded in the report.

Horizontal: Level

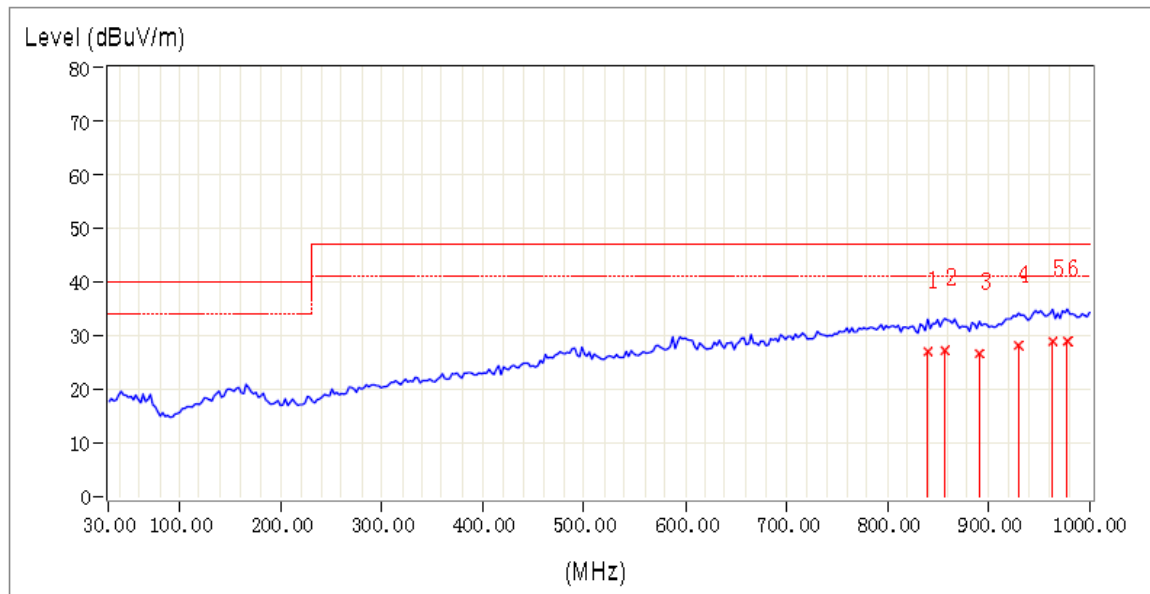


No.	Frequency MHz	Factor dB	Reading dBuV/m	Emission dBuV/m	Limit dBuV/m	Over Limit dB	Tower / Table	
							cm	deg
1	464.07	18.96	11.81	30.77	47.00	-16.23	200	154
*	2	495.60	19.38	15.91	47.00	-11.71	200	170
3	507.73	19.63	13.60	33.43	47.00	-13.57	200	326
4	934.52	27.74	1.76	29.50	47.00	-17.50	200	43
5	961.20	28.22	1.23	29.45	47.00	-17.55	200	105
6	967.87	28.08	1.23	29.31	47.00	-17.69	200	187

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. Emission Level = Reading Level + Factor.

**Vertical:
Level**



No.	Frequency MHz	Factor dB	Reading dBuV/m	Emission dBuV/m	Limit dBuV/m	Over Limit dB	Tower / Table	
							cm	deg
1	839.95	26.42	0.59	27.01	47.00	-19.99	100	95
2	856.92	26.44	0.77	27.21	47.00	-19.79	100	126
3	890.87	26.42	0.22	26.64	47.00	-20.36	100	251
4	929.67	27.57	0.60	28.17	47.00	-18.83	100	169
5	963.62	28.20	0.69	28.89	47.00	-18.11	100	296
*	6	978.17	28.12	0.83	28.95	-18.05	100	218

Note:

1. All Readings below 1GHz are Quasi-Peak, above are performed with peak and/or average measurements as necessary.
2. Emission Level = Reading Level + Factor.

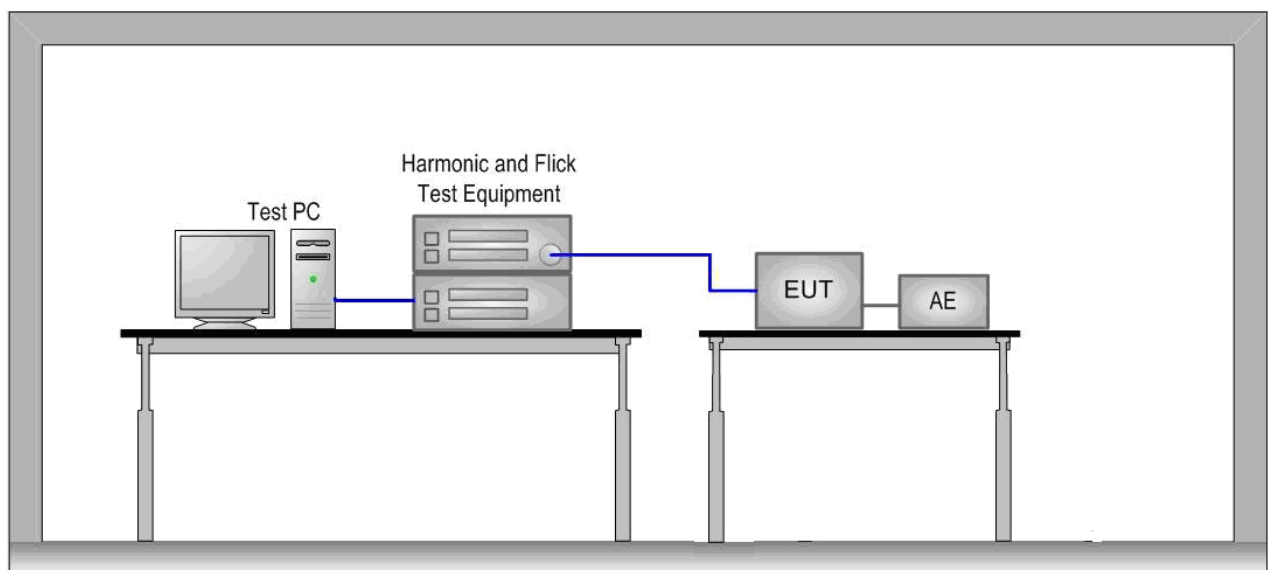
4.3 Voltage Changes, Voltage Fluctuations and Flicker

This part is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

4.3.1 Limits

Value	Limit
Pst	1,0
Plt	0,65
dt	3,3%
dc	3,3%
dmax	4,0%

4.3.2 Measurement test procedure



The equipment under test is placed on a wooden table with a height of 0,8 m in the EMC lab. The voltage changes, fluctuations and flicker were measured at the supply terminals of the EUT.

4.3.3 Results

Parameter values recorded during the test:

Vrms at the end of test (Volt): 229.74

Highest dt (%): 0.00

Time(mS) > dt: 0.0

Highest dc (%): 0.00

Highest dmax (%): 0.00

Highest Pst (10 min. period): 0.064

Test limit (%): 3.30 Pass

Test limit (mS): 500.0 Pass

Test limit (%): 3.30 Pass

Test limit (%): 4.00 Pass

Test limit: 1.000 Pass

5 Immunity Test

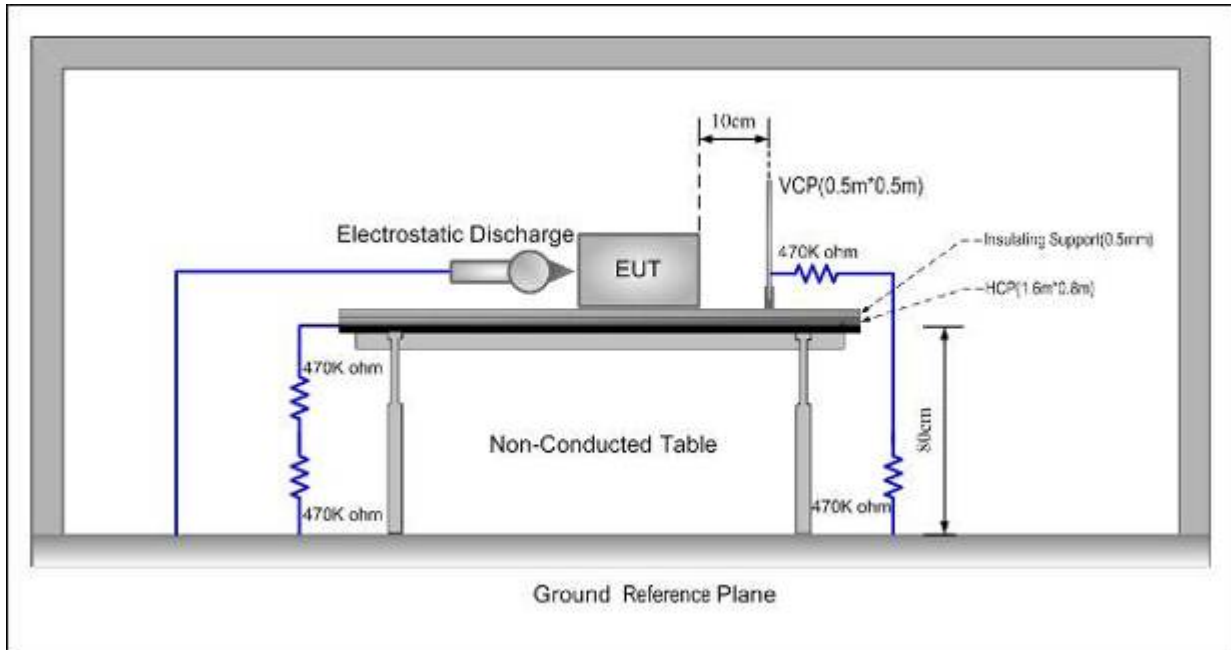
5.1 Performance Criteria Description in Clause 6 of EN 55024

Criterion A:	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B:	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C:	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

The particular performance criteria which are specified in the normative annexes take precedence over the corresponding parts of the general performance criteria. Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.

5.2 ESD

5.2.1 Test Procedures



1. Contact discharge was applied only to conductive surfaces of the EUT. Air discharge was applied only to non-conducted surfaces of the EUT.
2. The EUT was put on a 0.8m high wooden table for table-top equipment or 0.1m high for floor standing equipment standing on the ground reference plane (GRP).
3. A horizontal coupling plane(HCP) 1.6m by 0.8m in size was placed on the table, and the EUT with its cables were isolated from the HCP by an insulating support thick than 0.5mm. The VCP 0.5m by 0.5m in size while HCP were constructed from the same material type and thickness as that of the GRP, and connected to the GRP via a 470kΩ resistor at each end. The distance between EUT and any of the other metallic surfaces excepted the GRP, HCP and VCP was greater than 1m.
4. During the contact discharges, the tip of the discharge electrode was touching the EUT before the discharge switch is operated. During the air discharges, the round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the ESD generator was removed from the EUT, the generator is then retriggered for a new single discharge. For ungrounded product, a discharge cable with two resistances was used after each discharge to remove remnant electrostatic voltage.
5. The discharges shall be applied in two ways: a) contact discharges to the conductive surfaces and to coupling planes- The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points (a minimum of 50 discharges at each point). One of the test points shall be subjected to at least 50 indirect discharges (contact) to the centre of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Tests shall be performed at a maximum repetition rate of one discharge per second. b) air discharge at slots and apertures, and insulating surfaces: On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur; examples are openings at edges of keys, or in the covers of keyboards and telephone handsets. Such points are tested using the air discharge method. This investigation should be restricted to those areas normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

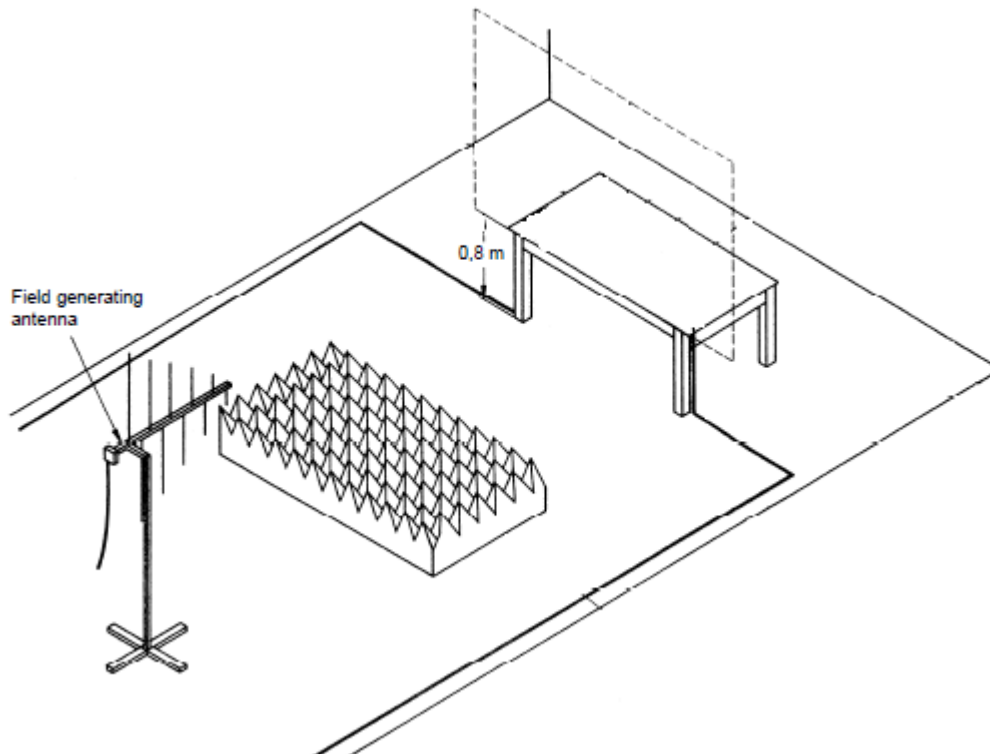
5.2.2 Results

Test point	Table (T) Floor (F)	Contact (C) Air (A)	Voltage (kV)	Number of discharge	Polarity (+ / -)	Opinion
Air contact	T	A	8	20	+ / -	A
Direct contact	T	C	4	200	+ / -	A
HCP	T	C	4	200	+ / -	A
VCP	T	C	4	200	+ / -	A

A: no loss of function.

5.3 Radio frequency electromagnetic fields

5.3.1 Measurement procedure



- 1 The EUT was placed on 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP. The tests normally shall be performed with the generating antenna facing each of four sides of the EUT. When equipment can be used in different orientations (e.g. vertical or horizontal) the test shall be performed on all possible sides of the EUT.
- 2 The tests are carried out with a field strength by 3 V/m (measured in the unmodulated field) with amplitude modulated signal by a depth of 80 % by a sinusoidal audio signal of 1 kHz. The logarithmic step was 1% and the dwell time was 3s dependent of the EUT cycle time.
- 3 The EUT shall be positioned so that the four sides of the EUT shall be exposed to the electromagnetic field in sequence. In each position the performance of the EUT will be investigated. In the case where the most sensitive surface side of the EUT is known throughout the frequency range (for example, via preliminary tests), testing may be restricted to that surface side only. Test was performed on subcontractor.

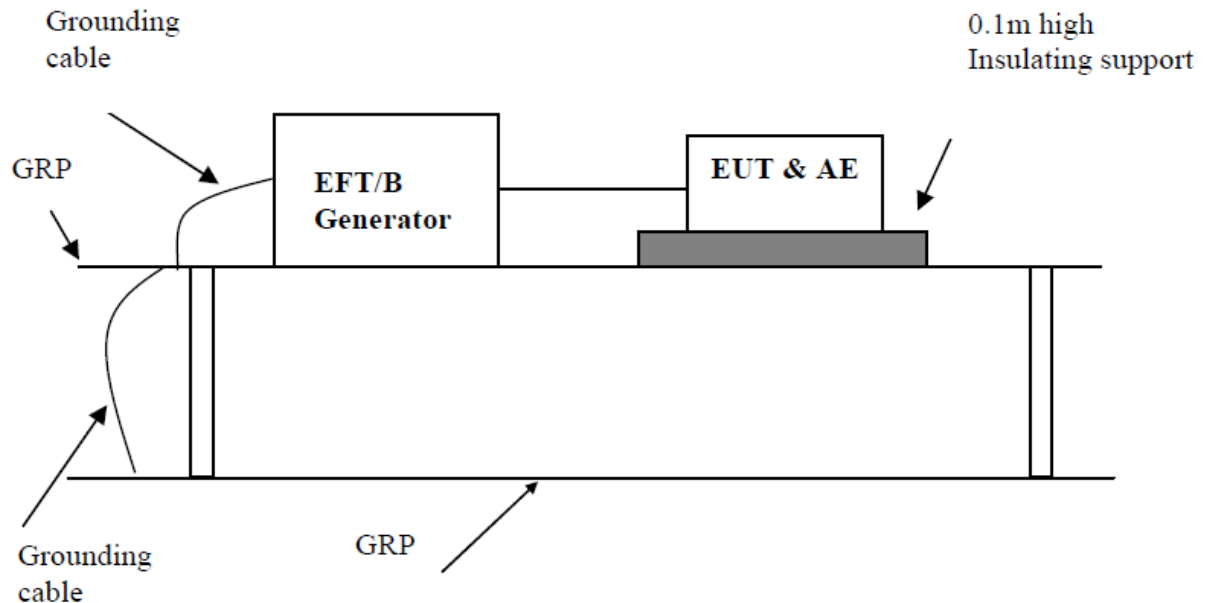
5.3.2 Results

Frequency Range	Voltage(RMS)	Modulation Frequency	Opinion
80M-1GHz	3V/m	1kHz,80%,AM	A

A: no loss of function.

5.4 Electrical Fast Transients

5.4.1 Measurement procedure



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0.1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The GRP shall project beyond the EUT and the clamp by at least 0.1m on all sides. The distance between the EUT and any other of the metallic surface except the GRP was greater than 0.5m. All cables to the EUT was placed on the insulation support 0.1m above GRP. Cables not subject to EFT was routed as far as possible from cable under test to minimize the coupling between the cables.
3. The length of signal and power cable between the EUT and EFT generator was 0.5m. If the cable is a non-detachable supply cable more than 0.5m, the excess length of this cable shall be folded to avoid a flat coil and situated at a distance of 0.1m above the GRP.

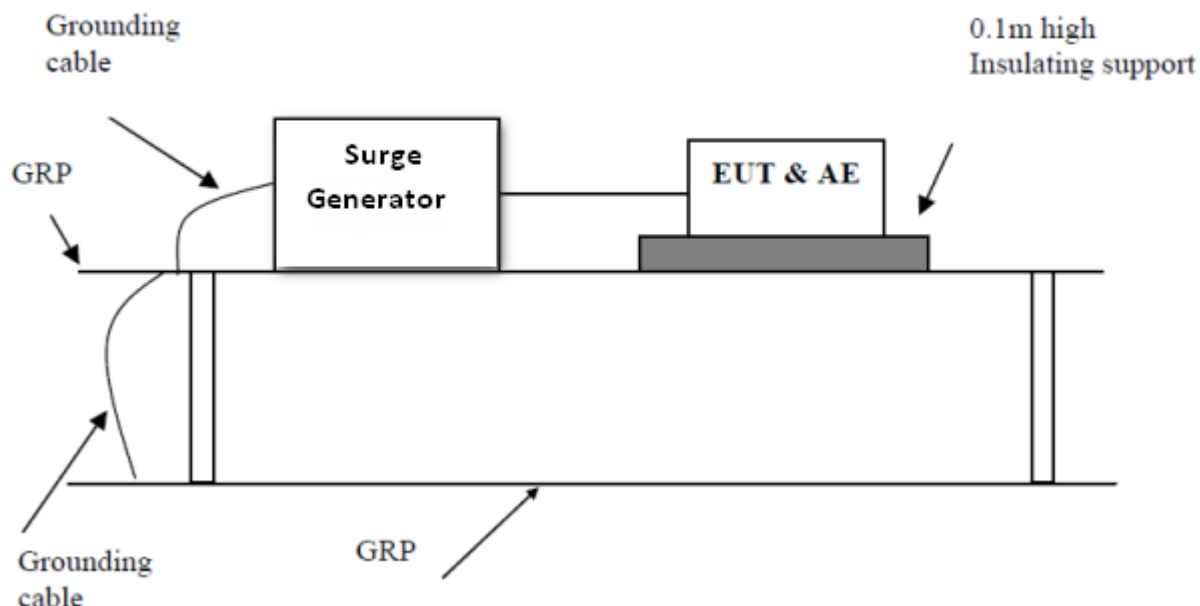
5.4.2 Results

Test port	Voltage (kV)	Polarity (+ / -)	Duration (s or min)	Waveform Tr / Th	Repetition Frequency (kHz)	Opinion
AC power line	1	+	2 min	5/50 ns	5	A
AC power line	1	-	2 min	5/50 ns	5	A

A: no loss of function.

5.5 Surge Immunity

5.5.1 Measurement procedure



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0.1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The 1,2/50 μ s surge was to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks were required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave so that the specified wave may be applied on the lines under test.
3. Five positive and five negative pulses each at 0°, 90°, 180° and at 270°. Time between successive pulses: 1 min.

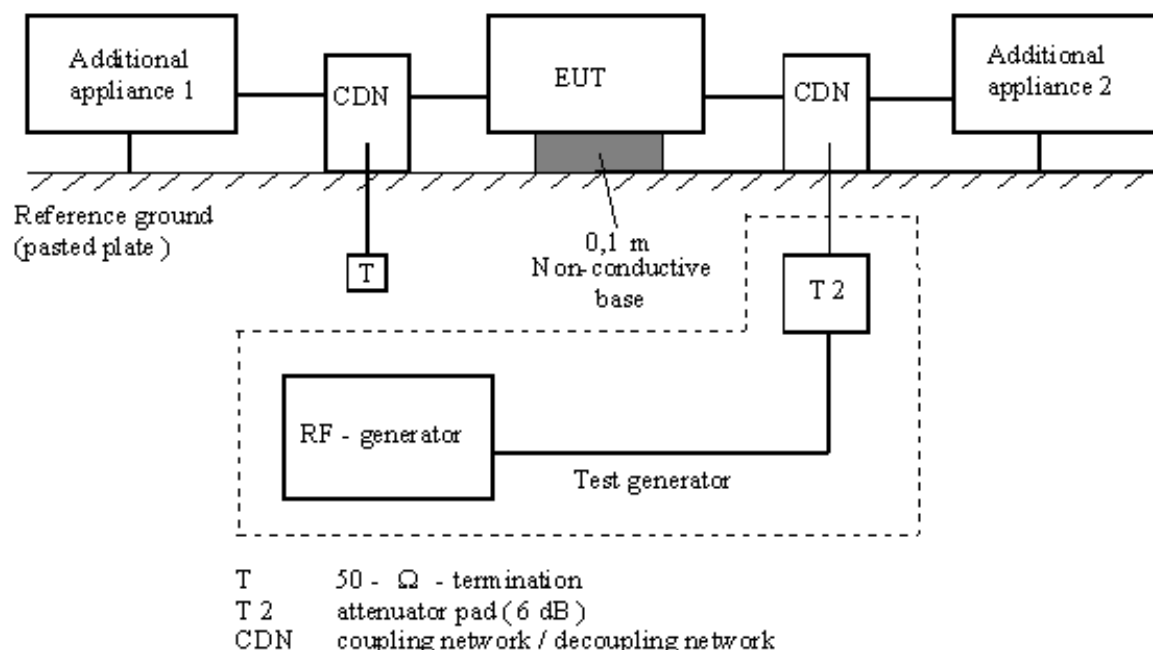
5.5.2 Results

Test mode	Polarity (+ / -)	Voltage (kV)	Waveform Tr / Th	Number of pulses	Opinion
Live-Neutral	+	0.5/1	1.2/50 μ s	5	A
Live-Neutral	-	0.5/1	1.2/50 μ s	5	A

A: no loss of function.

5.6 Injected currents(RF continues conducted)

5.6.1 Measurement procedure



1. The EUT was placed on an insulating support of 0.1m height above a ground reference Plane, arranged and connected to satisfy its functional requirement. All cables exiting the EUT was supported at a height of at least 30 mm above the ground reference plane.
2. The coupling and decoupling devices were required, they were located between 0,1 m and 0,3 m from the EUT. This distance was to be measured horizontally from the projection of the EUT on to the ground reference plane to the coupling and decoupling device.
3. The frequency range was swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80 % amplitude modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or to change coupling devices as necessary. Where the frequency was swept incrementally, the step size do not exceed 1 % of the preceding frequency value. The dwell time of the amplitude modulated carrier at each frequency was not less than the time necessary for the EUT to be exercised and to respond, and was not less than 3s.

5.6.2 Results

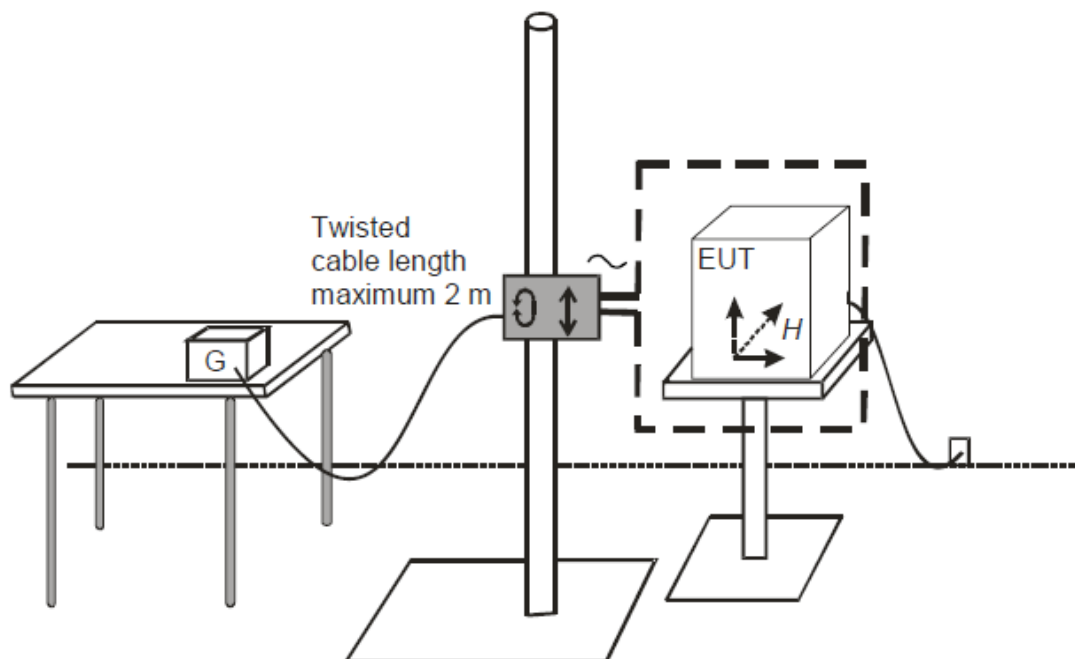
Test port	Voltage (rms)	Modulation Frequency	Frequency Range	Opinion
AC power line	3	1 kHz, 80%,AM	150 kHz - 80 MHz	A

A: no loss of function.

5.7 Power-frequency Magnetic field

The magnetic fields to which equipment is subjected may influence the reliable operation of equipment and systems.

5.7.1 Measurement procedure



The electromagnetic conditions of the laboratory shall be such as to guarantee the correct operation of the EUT in order not to influence the test results; otherwise, the tests shall be carried out in a Faraday cage. The plane of the inductive coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

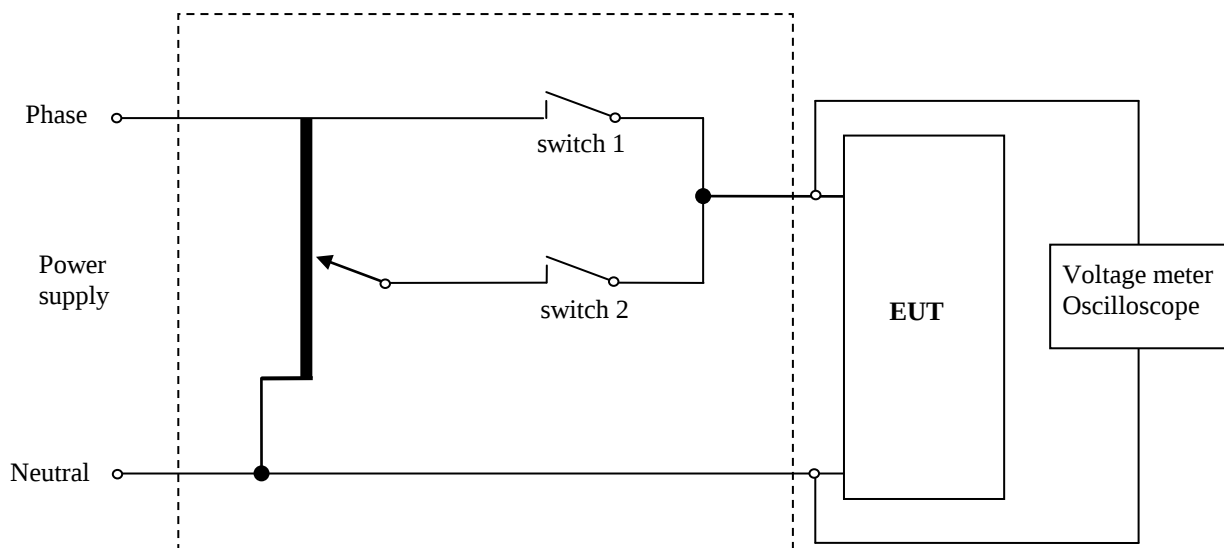
5.7.2 Results

Test Frequency	Field Level (A/m)	Duration (Second)	Axis of Orientation	Opinion
50/60Hz	1	60	X	A
50/60Hz	1	60	Y	A
50/60Hz	1	60	Z	A

A: no loss of function.

5.8 Voltage dips and Interruption

5.8.1 Measurement procedure



1. The EUT was placed on a ground reference plane (GRP) insulated by an insulating support 0.1 m thick and the GRP was placed on a 0.8m high wooden table for table-top equipment. For floor standing equipment, the EUT was placed on a 0.1m high wooden support above the GRP.
2. The test was performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer. Voltage change shall occur at zero crossing.
3. The EUT was tested for each selected combination of test level and duration with a sequence of three dips /interruptions with intervals of 10 s minimum. Each representative mode of operation was tested.

5.8.2 Results

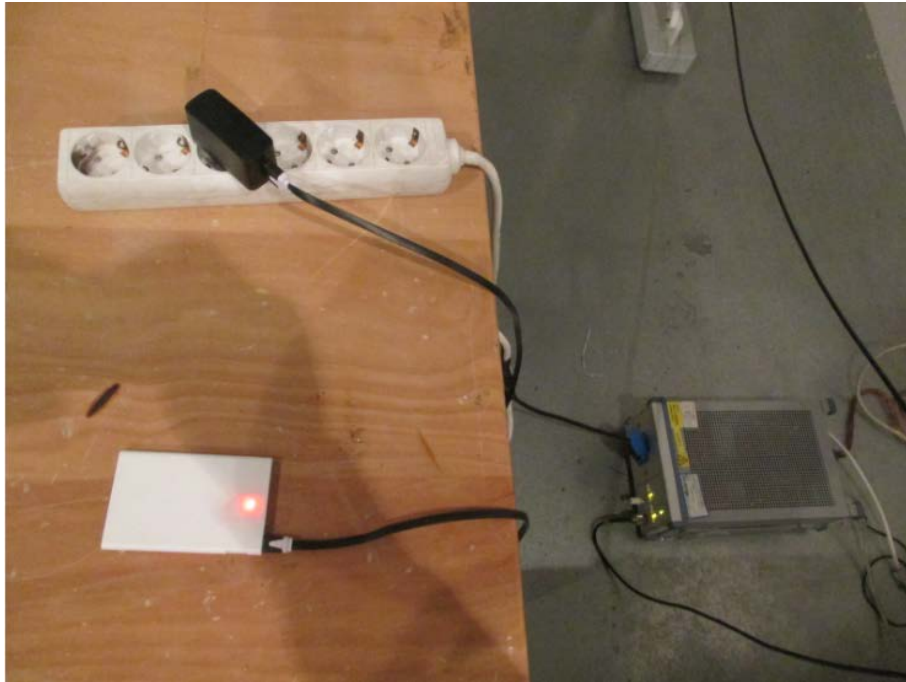
Supply voltage	Voltage in % (in V)	Duration in parts of period (in ms)	Opinion
Voltage dips	0 % (0V)	0,5 (10 ms)	B
Voltage dips	70 % (161V)	25 (500 ms)	B
Voltage interruptions	0 % (0 V)	250 (5000 ms)	B

A: no loss of function.

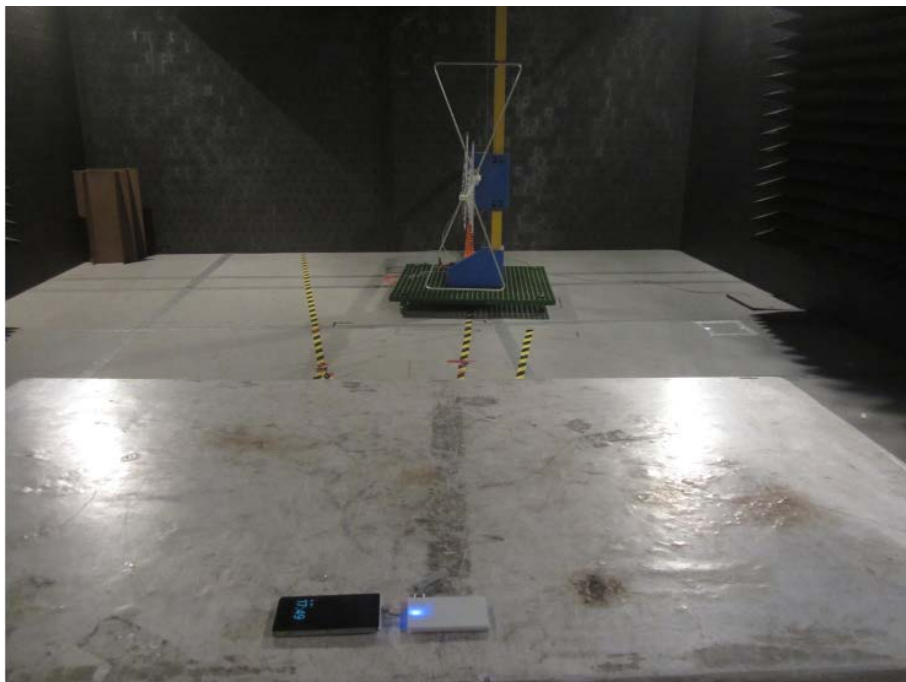
B: the appliance would not work normal during test, but after test it would recover.

6 Test setup Photos

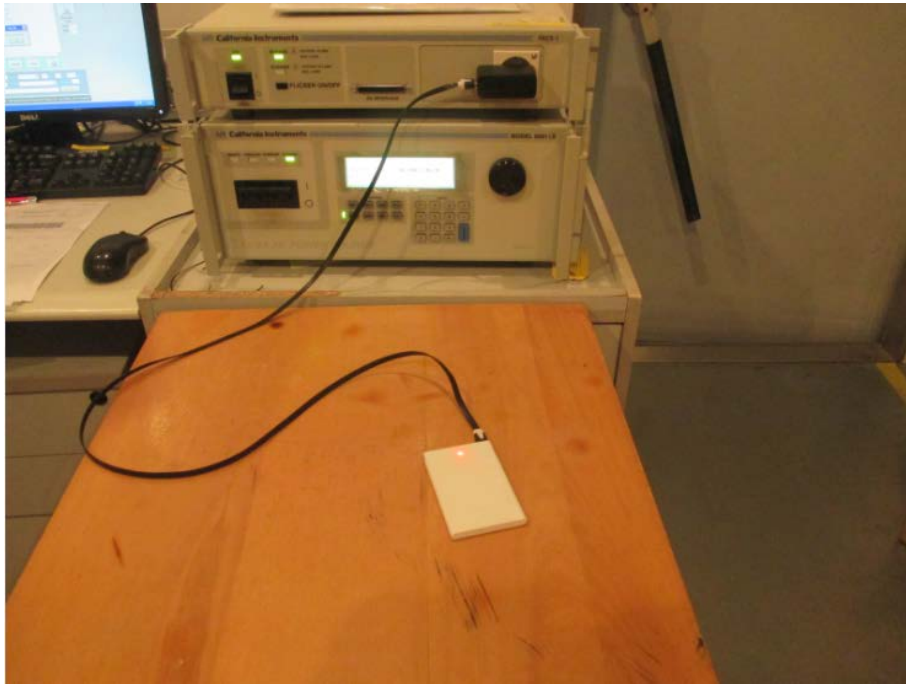
Conducted disturbance



Radiated disturbance



Flicker



Electrostatic Discharge



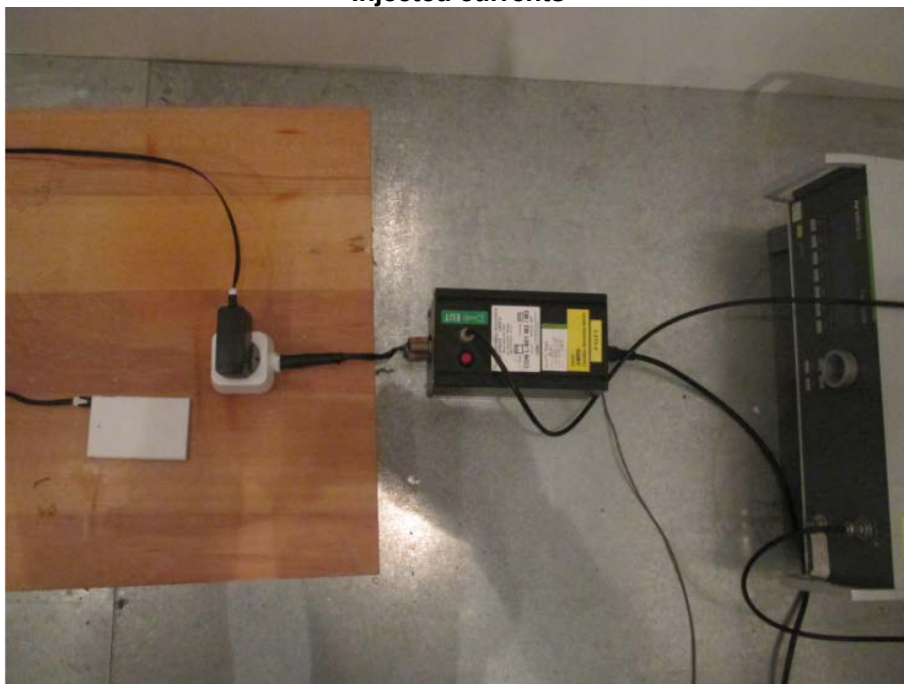
Radio frequency electromagnetic fields



Electrical Fast Transients/ Surge immunity/ Voltage dips and short interruption



Injected currents

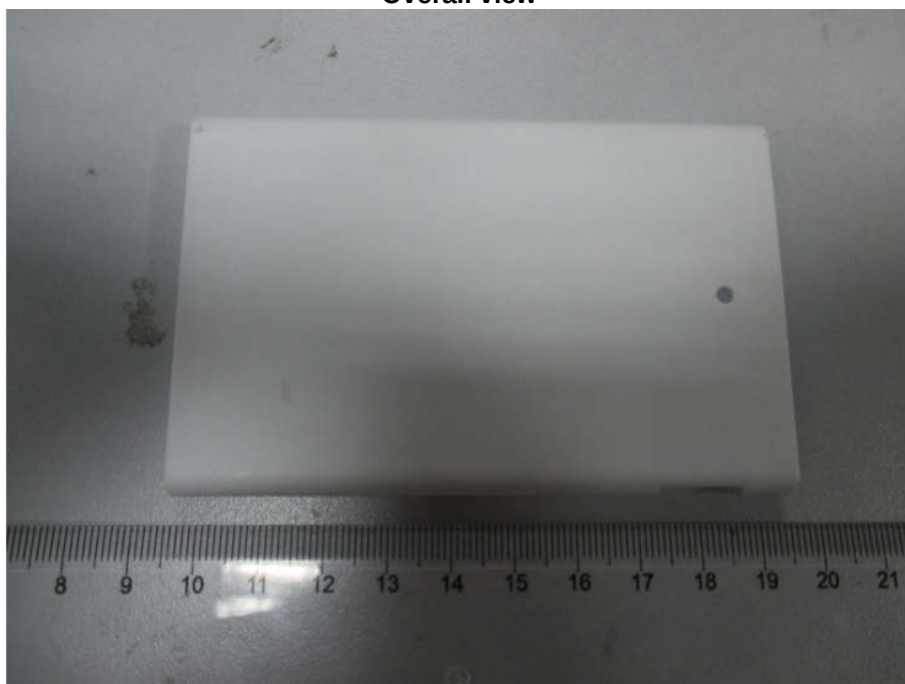


Power-frequency Magnetic field



7 EUT Photos

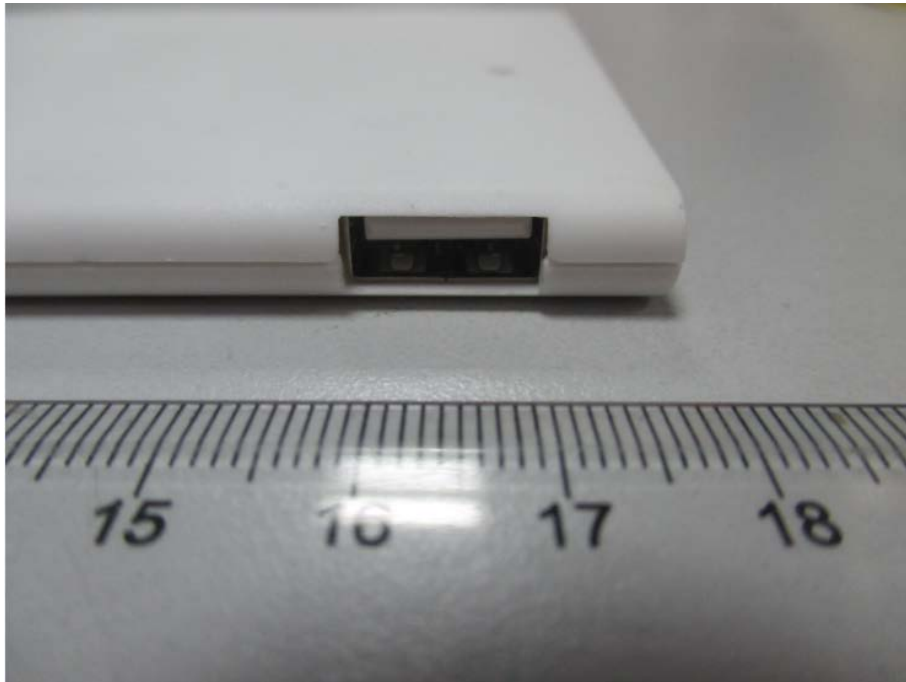
Overall view



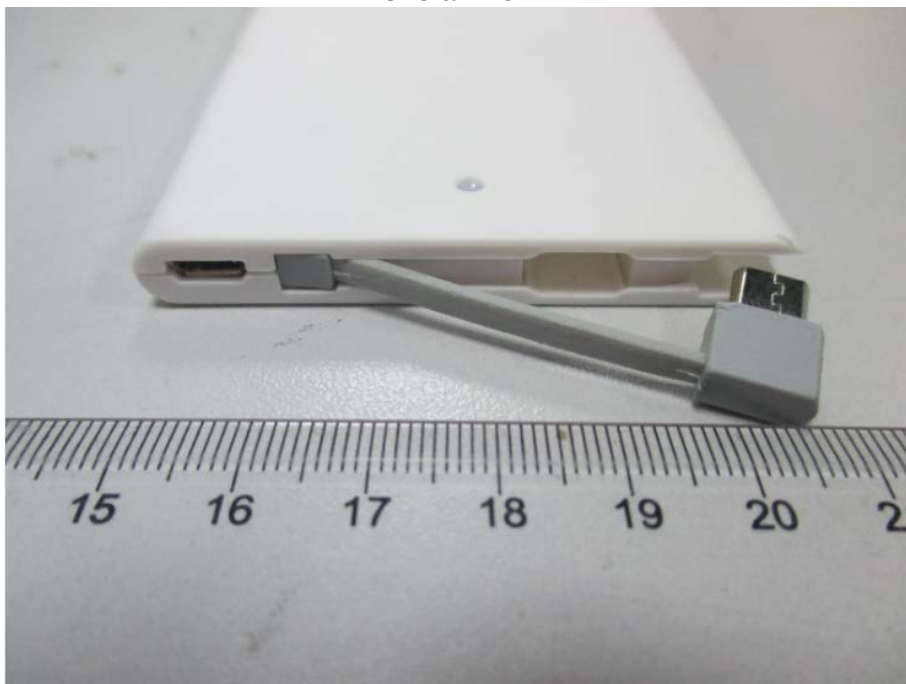
Overall view



Overall view



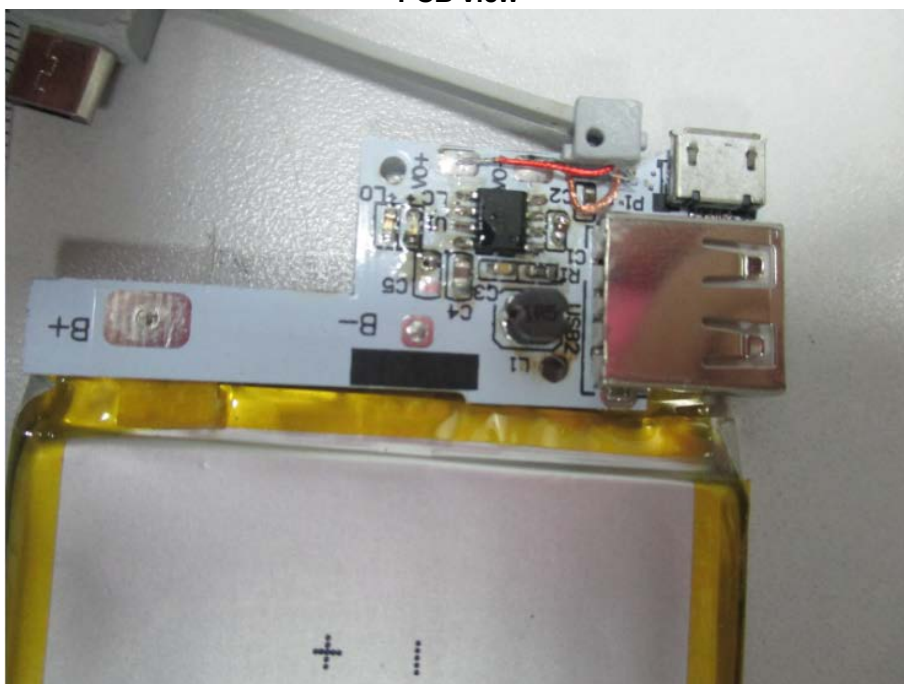
Overall view



Internal view



PCB view



PCB view

